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| Notice of References Cited | | | Application/Control No. | Applicant(s)/Patent Under Reexamination FAUTY ET AL. | |
| | | | Examiner David E. Graybill | Art Unit 2822 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-4,490,902 A | 01-1985 | Eytcheson et al. | 29/827 |
| | B | US-5,070,039 A | 12-1991 | Johnson et al. | 29/827 |
| | C | US-5,221,859 A | 06-1993 | Kobayashi et al. | 257/676 |
| | D | US-5,898,216 A | 04-1999 | Steffen, Francis | 257/679 |
| | E | US-6,071,758 A | 06-2000 | Steffen, Francis | 438/112 |
| | F | US-2004/0084756 A1 | 05-2004 | Kawakami et al. | 257/666 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------------|----------------|
| | N | JP 05067715 A | 03-1993 | Japan | ASANO et al. | H01L 23/50 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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